CHIPMETRICS

CHARACTERIZE UNDERSTAND ENSURE QUALITY OF 3D THIN FILMS WITHOUT CROSS SECTIONING Innovative metrology chips and wafers for process quality control in semiconductor manufacturing

 Our customers are on advanced materials and the microelectronics manufacturing sector, a rapidly growing and evolving industry

 ✓ We are a leading expert and innovator of 3D thin films conformality measurements.

 Our metrology solution applications are in thin film process development, process control and monitoring, as well as tool qualification and quality assurance.

TARGET MORE OD1

Founded 2019

Headquarters: Joensuu, Finland Customers worldwide: 40 (15 in Japan)

Sales agents in Japan: E&M, Advantec, ALD Japan

chipmetrics.jp www.chipmetrics.com



CHIPMETRICS

PRODUCTS AND EXPERTISE

- Metrology chips,
 - High Aspect Ratio test elements for R&D
- Pocket wafer concept
 - for thin film process quality control in manufacturing
- Measurement services
 - for metrology chips and wafers
- Design services
 - for customized test wafers

REFERENCE CASES

- Kokusai Electric
- Meidensha



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PocketWafer



VWR



